

December 7, 1964

LINEAR PHASOLVER MEASURING ENGINE

STAT

[REDACTED]

The principle road block to completion of the linear phasolver program was the preparation by [REDACTED] of a satisfactory master driver pattern. [REDACTED] has been making trial masters and [REDACTED] have been rejecting them since last spring. The one promising aspect of the situation is the possibility of using the most recent [REDACTED] driver master as is. The defects appear to be of two kinds:

- a) Blemishes and scratches which can probably be repaired;
- b) A systematic double frequency error which can probably be compensated electrically.

[REDACTED] is proceeding with one driver from [REDACTED] which he has sent to [REDACTED]

We went thru the exercise of estimating at this stage of the program what the eventual accuracy might be. According to [REDACTED]'s tests to date the electronic noise and stability will probably produce $\pm \frac{1}{2}$ micron random error which is the lower limit. The upper limit is estimated to be about $\pm 1\frac{1}{2}$ micron systematic error. How much of the $\pm 1\frac{1}{2}$ micron systematic error can be compensated and how close they can get to the $\pm \frac{1}{2}$ micron minimum random error cannot be determined yet.

[REDACTED] is considering the problem and will try to determine whether it can be done within the scope of the present program. [REDACTED] is now preparing working reproductions of [REDACTED]'s driver master pattern and also [REDACTED] is preparing a full length coupler bar pattern to work with the driver. [REDACTED] expected to have them done by Nov. 27 but ran into some machine trouble. He now expects to complete them by the end of this week, Dec. 11. If [REDACTED] delivers as expected, [REDACTED] still hopes to complete the assembly and be ready to demonstrate feasibility by Jan. 18, 1965.

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DDR - DUPE